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What is "Embedded - Microcontrollers"?

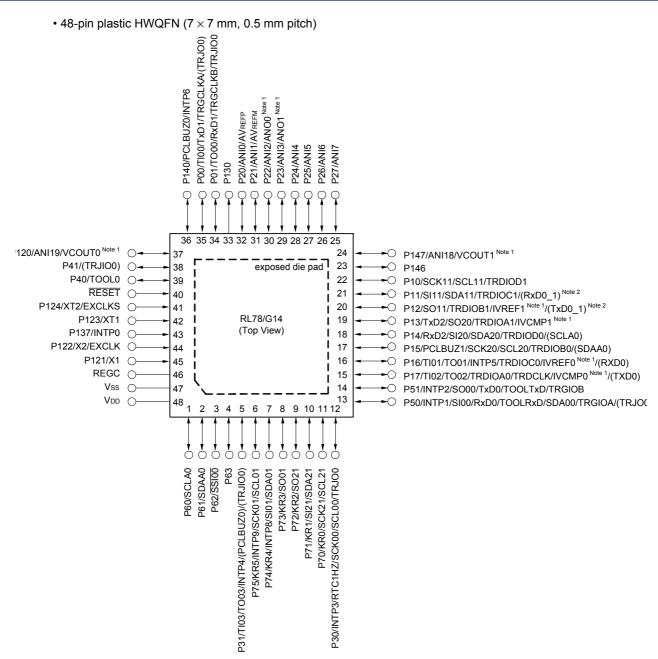
"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Obsolete
Core Processor	RL78
Core Size	16-Bit
Speed	32MHz
Connectivity	CSI, I <sup>2</sup> C, LINbus, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	38
Program Memory Size	256KB (256K x 8)
Program Memory Type	FLASH
EEPROM Size	8K x 8
RAM Size	24K x 8
Voltage - Supply (Vcc/Vdd)	1.6V ~ 5.5V
Data Converters	A/D 12x8/10b; D/A 2x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	52-LQFP
Supplier Device Package	52-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f104jjgfa-x0

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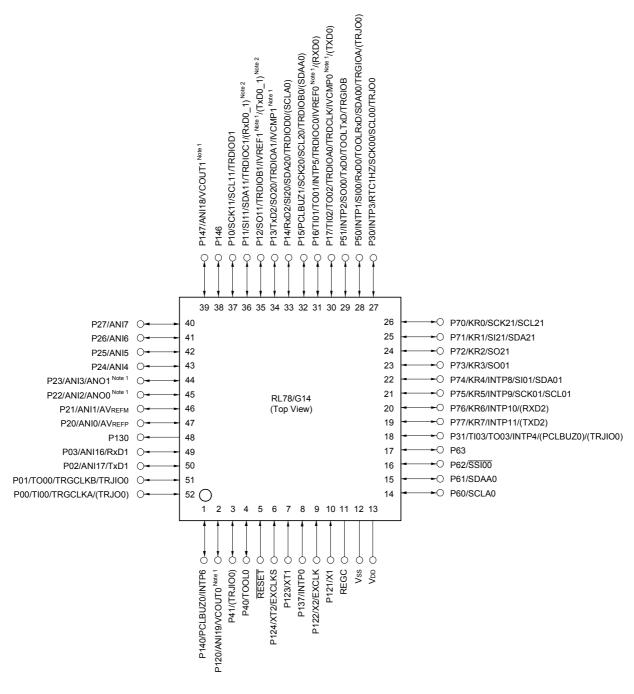
Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



- Note 1. Mounted on the 96 KB or more code flash memory products.
- Note 2. Mounted on the 384 KB or more code flash memory products.
- Caution Connect the REGC pin to Vss pin via a capacitor (0.47 to 1  $\mu$ F).
- Remark 1. For pin identification, see 1.4 Pin Identification.
- Remark 2. Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register 0, 1 (PIOR0, 1).
- Remark 3. It is recommended to connect an exposed die pad to Vss.

# 1.3.7 52-pin products

• 52-pin plastic LQFP (10 × 10 mm, 0.65 mm pitch)



Note 1. Mounted on the 96 KB or more code flash memory products.

Caution Connect the REGC pin to Vss pin via a capacitor (0.47 to 1  $\mu$ F).

Remark 1. For pin identification, see 1.4 Pin Identification.

Remark 2. Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register 0, 1 (PIOR0, 1).

[44-pin, 48-pin, 52-pin, 64-pin products (code flash memory 96 KB to 256 KB)]

Caution This outline describes the functions at the time when Peripheral I/O redirection register 0, 1 (PIOR0, 1) are set to 00H.

(1/2)

					(1/2)				
		44-pin	48-pin	52-pin	64-pin				
	Item	R5F104Fx	R5F104Gx	R5F104Jx	R5F104Lx				
		(x = F  to  H, J)	(x = F  to  H, J)	(x = F  to  H, J)	(x = F  to  H, J)				
Code flash me	mory (KB)	96 to 256	96 to 256	96 to 256	96 to 256				
Data flash mer	mory (KB)	8	8	8	8				
RAM (KB)		12 to 24 Note 12 to 24 Note 12 to 24 Note 12 to 24 Note							
Address space	<b>;</b>	1 MB							
Main system clock	High-speed system clock	X1 (crystal/ceramic) oscillation, external main system clock input (EXCLK) HS (high-speed main) mode: 1 to 20 MHz (VDD = 2.7 to 5.5 V), HS (high-speed main) mode: 1 to 16 MHz (VDD = 2.4 to 5.5 V), LS (low-speed main) mode: 1 to 8 MHz (VDD = 1.8 to 5.5 V), LV (low-voltage main) mode: 1 to 4 MHz (VDD = 1.6 to 5.5 V)							
	High-speed on-chip oscillator clock (fін)	HS (high-speed main)	mode: 1 to 32 MHz (V mode: 1 to 16 MHz (V node: 1 to 8 MHz (VD mode: 1 to 4 MHz (VD	DD = 2.4 to 5.5 V), D = 1.8 to 5.5 V),					
Subsystem clo	ck	XT1 (crystal) oscillatio	n, external subsystem o	clock input (EXCLKS) 3	2.768 kHz				
Low-speed on-	-chip oscillator clock	15 kHz (TYP.): V <sub>DD</sub> = 1	1.6 to 5.5 V						
General-purpo	se register	8 bits × 32 registers (8 bits × 8 registers × 4 banks)							
Minimum instru	uction execution time	0.03125 μs (High-speed on-chip oscillator clock: fiн = 32 MHz operation)							
		0.05 μs (High-speed s	ystem clock: fmx = 20 M	1Hz operation)					
		30.5 μs (Subsystem cl	ock: fsuв = 32.768 kHz	operation)					
Instruction set		Multiplication (8 bits :     Multiplication and Ac	its)  r/logical operation (8/16 $\times$ 8 bits, 16 bits $\times$ 16 bits  cumulation (16 bits $\times$ 16  and bit manipulation (Se	s), Division (16 bits ÷ 16 6 bits + 32 bits)					
I/O port	Total	40	44	48	58				
	CMOS I/O	31	34	38	48				
	CMOS input	5	5	5	5				
	CMOS output	_	1	1	1				
	N-ch open-drain I/O (6 V tolerance)	4	4	4	4				
Timer	16-bit timer	8 channels (TAU: 4 channels, Tim	er RJ: 1 channel, Timer	RD: 2 channels, Timer	RG: 1 channel)				
	Watchdog timer	1 channel							
	Real-time clock (RTC)	1 channel							
	12-bit interval timer	1 channel							
	Timer output	Timer outputs: 14 channels PWM outputs: 9 channels							
		1 • 1 Hz (subsystem clock: fsub = 32.768 kHz)							

(Note is listed on the next page.)

(2/2)

		40 :	(2/2)				
		48-pin	64-pin				
Item		R5F104Gx	R5F104Lx				
		(x = K, L)	(x = K, L)				
Clock output/buzzer outp	out	2	2				
		• 2.44 kHz, 4.88 kHz, 9.76 kHz, 1.25 MHz, 2.5	5 MHz, 5 MHz, 10 MHz				
		(Main system clock: fMAIN = 20 MHz operation					
		• 256 Hz, 512 Hz, 1.024 kHz, 2.048 kHz, 4.09					
		(Subsystem clock: fsub = 32.768 kHz opera	· T				
8/10-bit resolution A/D co	onverter	10 channels	12 channels				
D/A converter		2 channels					
Comparator		2 channels					
Serial interface		[48-pin products]					
		CSI: 2 channels/UART (UART supporting LI	N-bus): 1 channel/simplified I <sup>2</sup> C: 2 channels				
		CSI: 1 channel/UART: 1 channel/simplified I	<sup>2</sup> C: 1 channel				
		CSI: 2 channels/UART: 1 channel/simplified	I <sup>2</sup> C: 2 channels				
		[64-pin products]					
		CSI: 2 channels/UART (UART supporting LI	•				
		CSI: 2 channels/UART: 1 channel/simplified					
		CSI: 2 channels/UART: 1 channel/simplified	I <sup>2</sup> C: 2 channels				
	I <sup>2</sup> C bus	1 channel	1 channel				
Data transfer controller (I	DTC)	32 sources	33 sources				
Event link controller (ELC	C)	Event input: 22					
		Event trigger output: 9					
Vectored interrupt	Internal	24	24				
sources	External	10	13				
Key interrupt		6	8				
Reset		Reset by RESET pin					
l		Internal reset by watchdog timer					
		Internal reset by power-on-reset					
		Internal reset by voltage detector					
		Internal reset by illegal instruction execution	Note				
		Internal reset by RAM parity error					
		Internal reset by illegal-memory access					
Power-on-reset circuit		• Power-on-reset: 1.51 ±0.04 V (T <sub>A</sub> = -40	· · · · · · · · · · · · · · · · · · ·				
		1.51 $\pm 0.06$ V (TA = $-40$ • Power-down-reset: 1.50 $\pm 0.04$ V (TA = $-40$	•				
		1.50 ±0.04 V (TA = -40	•				
Voltage detector		1.63 V to 4.06 V (14 stages)					
On-chip debug function		Provided					
Power supply voltage		V <sub>DD</sub> = 1.6 to 5.5 V (T <sub>A</sub> = -40 to +85°C)					
1 Ower Supply Voltage		V <sub>DD</sub> = 2.4 to 5.5 V (T <sub>A</sub> = -40 to +105°C)					
Operating ambient temper	erature	TA = -40 to +85°C (A: Consumer applications,	D: Industrial applications)				
	Jature	$T_A = -40 \text{ to } +35 \text{ C}$ (A. Consumer applications, $T_A = -40 \text{ to } +105 \text{°C}$ (G: Industrial applications					
		(3. madound applications	,				

**Note** The illegal instruction is generated when instruction code FFH is executed.

Reset by the illegal instruction execution is not issued by emulation with the in-circuit emulator or on-chip debug emulator.

### 2.2 Oscillator Characteristics

# 2.2.1 X1, XT1 characteristics

 $(TA = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{VDD} \le 5.5 \text{ V}, \text{Vss} = 0 \text{ V})$ 

Resonator	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock oscillation frequency (fx) Note	Ceramic resonator/	$2.7~\text{V} \leq \text{Vdd} \leq 5.5~\text{V}$	1.0		20.0	MHz
	crystal resonator	2.4 V ≤ V <sub>DD</sub> < 2.7 V	1.0		16.0	
		1.8 V ≤ V <sub>DD</sub> < 2.4 V	1.0		8.0	
		1.6 V ≤ V <sub>DD</sub> < 1.8 V	1.0		4.0	
XT1 clock oscillation frequency (fxT) Note	Crystal resonator		32	32.768	35	kHz

Note Indicates only permissible oscillator frequency ranges. Refer to AC Characteristics for instruction execution time.

Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.

Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

Remark When using the X1 oscillator and XT1 oscillator, refer to 5.4 System Clock Oscillator in the RL78/G14 User's Manual.

# 2.2.2 On-chip oscillator characteristics

 $(TA = -40 \text{ to } +85^{\circ}C, 1.6 \text{ V} \le \text{VDD} \le 5.5 \text{ V}, \text{ Vss} = 0 \text{ V})$ 

Oscillators	Parameters	C	conditions	MIN.	TYP.	MAX.	Unit
High-speed on-chip oscillator clock frequency Notes 1, 2	fı⊢		1		32	MHz	
High-speed on-chip oscillator clock frequency		-20 to +85°C	$1.8 \text{ V} \le \text{Vdd} \le 5.5 \text{ V}$	-1.0		+1.0	%
accuracy			1.6 V ≤ V <sub>DD</sub> < 1.8 V	-5.0		+5.0	%
		-40 to -20°C	1.8 V ≤ VDD < 5.5 V	-1.5		+1.5	%
			1.6 V ≤ V <sub>DD</sub> < 1.8 V	-5.5		+5.5	%
Low-speed on-chip oscillator clock frequency	fı∟				15		kHz
Low-speed on-chip oscillator clock frequency accuracy				-15		+15	%

**Note 1.** High-speed on-chip oscillator frequency is selected with bits 0 to 4 of the option byte (000C2H) and bits 0 to 2 of the HOCODIV register.

Note 2. This only indicates the oscillator characteristics. Refer to AC Characteristics for instruction execution time.



### 2.3 DC Characteristics

### 2.3.1 Pin characteristics

(TA = -40 to +85°C, 1.6 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

Items	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Output current, high Note 1	Іон1	Per pin for P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P130, P140 to P147	1.6 V ≤ EVDD0 ≤ 5.5 V			-10.0 Note 2	mA
		Total of P00 to P04, P40 to P47,	4.0 V ≤ EVDD0 ≤ 5.5 V			-55.0	mA
		(When duty ≤ 70% Note 3)  1.8  1.6	2.7 V ≤ EV <sub>DD0</sub> < 4.0 V			-10.0	mA
			1.8 V ≤ EVDD0 < 2.7 V			-5.0	mA
			1.6 V ≤ EV <sub>DD0</sub> < 1.8 V			-2.5	mA
			4.0 V ≤ EVDD0 ≤ 5.5 V			-80.0	mA
		P30, P31, P50 to P57,	2.7 V ≤ EVDD0 < 4.0 V			-19.0	mA
		P64 to P67, P70 to P77, P80 to P87, P100, P101, P110,	1.8 V ≤ EVDD0 < 2.7 V			-10.0	mA
		P111, P146, P147 (When duty ≤ 70% Note 3)	1.6 V ≤ EVDD0 < 1.8 V			-5.0	mA
		Total of all pins (When duty ≤ 70% Note 3)	1.6 V ≤ EVDD0 ≤ 5.5 V			-135.0 Note 4	mA
	Іон2	Per pin for P20 to P27, P150 to P156	1.6 V ≤ VDD ≤ 5.5 V			-0.1 Note 2	mA
		Total of all pins (When duty ≤ 70% Note 3)	1.6 V ≤ VDD ≤ 5.5 V			-1.5	mA

Note 1. Value of current at which the device operation is guaranteed even if the current flows from the EVDDO, EVDD1, VDD pins to an output pin.

**Note 3.** Specification under conditions where the duty factor  $\leq 70\%$ .

The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

• Total output current of pins = (IoH  $\times$  0.7)/(n  $\times$  0.01) <Example> Where n = 80% and IoH = -10.0 mA Total output current of pins = (-10.0  $\times$  0.7)/(80  $\times$  0.01)  $\approx$  -8.7 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor.

A current higher than the absolute maximum rating must not flow into one pin.

Note 4. -100 mA for industrial applications (R5F104xxDxx, R5F104xxGxx).

Caution P00, P02 to P04, P10, P11, P13 to P15, P17, P30, P43 to P45, P50 to P55, P71, P74, P80 to P82, and P142 to P144 do not output high level in N-ch open-drain mode.

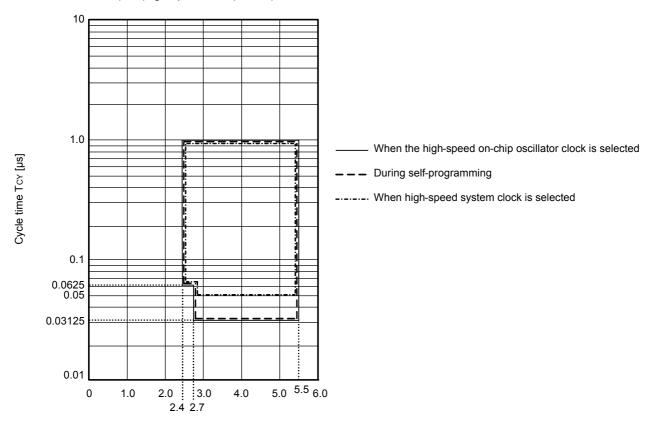
**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

Note 2. Do not exceed the total current value.

Minimum Instruction Execution Time during Main System Clock Operation

Supply voltage VDD [V]

Tcy vs Vdd (HS (high-speed main) mode)



- $\textbf{Remark 1.} \ \ p: CSI \ number \ (p = 00, \, 01, \, 10, \, 11, \, 20, \, 21, \, 30, \, 31), \ m: \ Unit \ number \ (m = 0, \, 1), \\$ 
  - n: Channel number (n = 0 to 3), g: PIM number (g = 0, 1, 3 to 5, 14)
- Remark 2. fmck: Serial array unit operation clock frequency
  - (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,
  - n: Channel number (mn = 00 to 03, 10 to 13))

## (6) Communication at different potential (1.8 V, 2.5 V, 3 V) (UART mode)

(TA = -40 to +85°C, 1.6 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

Parameter	Symbol	Conditions		٠ ٠	-speed main) node	,	speed main) node	,	voltage main) mode	Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Transfer rate		reception	$4.0 \text{ V} \le \text{EV}_{DD0} \le 5.5 \text{ V},$ $2.7 \text{ V} \le \text{V}_{b} \le 4.0 \text{ V}$		f <sub>MCK</sub> /6 Note 1		f <sub>MCK</sub> /6 Note 1		f <sub>MCK</sub> /6 Note 1	bps
			Theoretical value of the maximum transfer rate fmck = fclk Note 4		5.3		1.3		0.6	Mbps
			$2.7 \text{ V} \le \text{EV}_{\text{DD0}} < 4.0 \text{ V},$ $2.3 \text{ V} \le \text{V}_{\text{b}} \le 2.7 \text{ V}$		f <sub>MCK</sub> /6 Note 1		f <sub>MCK</sub> /6 Note 1		f <sub>MCK</sub> /6 Note 1	bps
			Theoretical value of the maximum transfer rate folk Note 4		5.3		1.3		0.6	Mbps
			$1.8 \text{ V} \le \text{EV}_{\text{DD0}} < 3.3 \text{ V},$ $1.6 \text{ V} \le \text{V}_{\text{b}} \le 2.0 \text{ V}$		fмск/6 Notes 1, 2, 3		fмск/6 Notes 1, 2		fмск/6 Notes 1, 2	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK Note 4		5.3		1.3		0.6	Mbps

Note 1. Transfer rate in the SNOOZE mode is 4800 bps only.

However, the SNOOZE mode cannot be used when FRQSEL4 = 1.

Note 2. Use it with  $EVDD0 \ge V_b$ .

Note 3. The following conditions are required for low voltage interface when EVDDO < VDD.

 $2.4~V \leq EV_{DD0} < 2.7~V;$  MAX. 2.6~Mbps

 $1.8 \text{ V} \leq \text{EV}_{\text{DD0}} < 2.4 \text{ V}$ : MAX. 1.3 Mbps

**Note 4.** The maximum operating frequencies of the CPU/peripheral hardware clock (fcLK) are:

HS (high-speed main) mode: 32 MHz ( $2.7 \text{ V} \le \text{VdD} \le 5.5 \text{ V}$ )

16 MHz (2.4 V  $\leq$  VDD  $\leq$  5.5 V)

LS (low-speed main) mode: 8 MHz (1.8 V  $\leq$  VDD  $\leq$  5.5 V) LV (low-voltage main) mode: 4 MHz (1.6 V  $\leq$  VDD  $\leq$  5.5 V)

Caution Select the TTL input buffer for the RxDq pin and the N-ch open drain output (VDD tolerance (for the 30- to 52-pin products)/EVDD tolerance (for the 64- to 100-pin products)) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

Remark 1. Vb [V]: Communication line voltage

**Remark 2.** q: UART number (q = 0 to 3), g: PIM and POM number (g = 0, 1, 5, 14)

Remark 3. fmck: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

n: Channel number (mn = 00 to 03, 10 to 13)

Remark 4. UART2 cannot communicate at different potential when bit 1 (PIOR01) of peripheral I/O redirection register 0 (PIOR0) is

# (8) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (master mode, SCKp... internal clock output)

(TA = -40 to +85°C, 1.8 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

Parameter	Symbol		Conditions	HS (high-s main) mo		LS (low-speed mode	,	LV (low-vo main) mo	•	Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	tkcy1	tkcy1 ≥ 4/fclk	$ \begin{aligned} 4.0 & \ V \leq EV_{DD0} \leq 5.5 \ V, \\ 2.7 & \ V \leq V_b \leq 4.0 \ V, \\ C_b & = 30 \ pF, \ R_b = 1.4 \ k\Omega \end{aligned} $	300		1150		1150		ns
			$ \begin{aligned} 2.7 & \ V \leq EV_{DDO} < 4.0 \ V, \\ 2.3 & \ V \leq V_b \leq 2.7 \ V, \\ C_b & = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{aligned} $	500		1150		1150		ns
			$ \begin{aligned} &1.8 \text{ V} \leq \text{EV}_{\text{DDO}} < 3.3 \text{ V}, \\ &1.6 \text{ V} \leq \text{V}_{\text{b}} \leq 2.0 \text{ V Note}, \\ &C_{\text{b}} = 30 \text{ pF},  R_{\text{b}} = 5.5 \text{ k}\Omega \end{aligned} $	1150		1150		1150		ns
width		$4.0 \text{ V} \le \text{EV}_{\text{DDO}} \le 5.5 \text{ V},$ $2.7 \text{ V} \le \text{V}_{\text{b}} \le 4.0 \text{ V},$ $\text{C}_{\text{b}} = 30 \text{ pF}, \text{R}_{\text{b}} = 1.4 \text{ k}\Omega$		tксү1/2 - 75		tксү1/2 - 75		tксү1/2 - 75		ns
		$\begin{split} 2.7 \ V &\leq EV_{DD0} < 4.0 \ V, \\ 2.3 \ V &\leq V_b \leq 2.7 \ V, \\ C_b &= 30 \ pF, \ R_b = 2.7 \ k\Omega \end{split}$		tkcy1/2 - 170		tксү1/2 - 170		tксу1/2 - 170		ns
		1.8 V $\leq$ EV <sub>DD0</sub> $<$ 3.3 V, 1.6 V $\leq$ V <sub>b</sub> $\leq$ 2.0 V Note, C <sub>b</sub> = 30 pF, R <sub>b</sub> = 5.5 kΩ		tkcy1/2 - 458		tkcy1/2 - 458		tkcy1/2 - 458		ns
SCKp low-level width	tKL1	4.0 V ≤ EVDD0 2.7 V ≤ Vb ≤ 4. Cb = 30 pF, Rb	0 V,	tксү1/2 - 12		tkcy1/2 - 50		tксү1/2 - 50		ns
		2.7 V ≤ EVDD0 2.3 V ≤ Vb ≤ 2 Cb = 30 pF, Rb	7 V,	tксү1/2 - 18		tkcy1/2 - 50		tксү1/2 - 50		ns
		1.8 V ≤ EVDD0 1.6 V ≤ Vb ≤ 2 Cb = 30 pF, Rb	0 V Note,	tkcy1/2 - 50		tксү1/2 - 50		tксү1/2 - 50		ns

Note Use it with  $EVDD0 \ge V_b$ .

Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (VDD tolerance (for the 30- to 52-pin products)/EVDD tolerance (for the 64- to 100-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

(Remarks are listed two pages after the next page.)

# (9) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (slave mode, SCKp... external clock input)

(TA = -40 to +85°C, 1.8 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

Parameter	Symbol	Cor	nditions	, ,	h-speed mode		r-speed mode		-voltage mode	Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	tkCY2	$4.0 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.5 \text{ V},$	24 MHz < fmck	14/fмск		_		_		ns
Note 1		$2.7~V \leq V_b \leq 4.0~V$	20 MHz < fмcк ≤ 24 MHz	12/fмск		_		_		ns
			8 MHz < fмcк ≤ 20 MHz	10/fмск		_		_		ns
			4 MHz < fмcк ≤ 8 MHz	8/fмск		16/fмск		_		ns
			fмcк ≤ 4 MHz	6/fмск		10/fмск		10/fмск		ns
		$2.7 \text{ V} \le \text{EV}_{\text{DD0}} < 4.0 \text{ V},$	24 MHz < fmck	20/fмск		_		_		ns
		$2.3~V \leq V_b \leq 2.7~V$	20 MHz < fмcк ≤ 24 MHz	16/fмск		_		_		ns
			16 MHz < fмcк ≤ 20 MHz	14/fмск		_		_		ns
			8 MHz < fмcк ≤ 16 MHz	12/fмск		_		_		ns
			4 MHz < fмcк ≤ 8 MHz	8/fмск		16/fмск		_		ns
			fмcк ≤ 4 MHz	6/fмск		10/fмск		10/fмск		ns
		1.8 V ≤ EVDD0 < 3.3 V,	24 MHz < fmck	48/fмск		_		_		ns
		1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2	20 MHz < fмcк ≤ 24 MHz	36/fмск		_		_		ns
		Note 2	16 MHz < fмcк ≤ 20 MHz	32/fмск		_		_		ns
			8 MHz < fмcк ≤ 16 MHz	26/fмск		_		_		ns
			4 MHz < fмcк ≤ 8 MHz	16/fмск		16/fмск		_		ns
			fмcк ≤ 4 MHz	10/fмск		10/fмск		10/fмск		ns
SCKp high-/ low-level width	tĸH2, tĸL2	4.0 V ≤ EVDD0 ≤ 5.5 V, 2	2.7 V ≤ V <sub>b</sub> ≤ 4.0 V	tксү2/2 - 12		tkcy2/2 - 50		tксү2/2 - 50		ns
		2.7 V ≤ EVDD0 < 4.0 V, 2	$2.3~V \leq V_b \leq 2.7~V$	tксү2/2 - 18		tkcy2/2 - 50		tксү2/2 - 50		ns
		1.8 V ≤ EVDD0 < 3.3 V,	$1.6 \text{ V} \leq \text{V}_b \leq 2.0 \text{ V Note 2}$	tксү2/2 - 50		tkcy2/2 - 50		tксү2/2 - 50		ns
SIp setup time (to SCKp↑) Note 3	tsık2	4.0 V ≤ EVDD0 ≤ 5.5 V, 2	$2.7 \text{ V} \le \text{V}_{\text{b}} \le 4.0 \text{ V}$	1/fмск + 20		1/fмск + 30		1/fмск + 30		ns
		2.7 V ≤ EVDD0 < 4.0 V, 2	$2.3~V \leq V_b \leq 2.7~V$	1/fмск + 20		1/fмск + 30		1/fмск + 30		ns
		1.8 V ≤ EVDD0 < 3.3 V,	$1.6~\text{V} \leq \text{V}_\text{b} \leq 2.0~\text{V}~\text{Note}~2$	1/fмск + 30		1/fмск + 30		1/fмск + 30		ns
SIp hold time (from SCKp↑) Note 4	tksi2			1/fмск + 31		1/fмск + 31		1/fмск + 31		ns
Delay time from SCKp↓ to SOp	tkso2	$4.0 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V}, \Omega$ Cb = 30 pF, Rb = 1.4 k $\Omega$			2/fмск + 120		2/fмск + 573		2/fмск + 573	ns
output Note 5		$2.7 \text{ V} \le \text{EV}_{\text{DD0}} < 4.0 \text{ V}, \Omega$ Cb = 30 pF, Rb = 2.7 k $\Omega$			2/fмск + 214		2/fмск + 573		2/fмск + 573	ns
		1.8 V ≤ EV <sub>DD0</sub> < 3.3 V, C <sub>b</sub> = 30 pF, Rv = 5.5 kΩ	$1.6 \text{ V} \le \text{V}_b \le 2.0 \text{ V} \text{ Note 2},$		2/fмск + 573		2/fмск + 573		2/fмск + 573	ns

 $(\textbf{Notes},\,\textbf{Caution},\, \text{and}\,\, \textbf{Remarks}$  are listed on the next page.)

## 2.5.2 Serial interface IICA

## (1) I<sup>2</sup>C standard mode

(TA = -40 to +85°C, 1.6 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

Parameter	Symbol	С	conditions	HS (high-sp	,	LS (low-sp mo	eed main) ode	,	ltage main) ode	Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCLA0 clock	fscL	Standard mode:	2.7 V ≤ EVDD0 ≤ 5.5 V	0	100	0	100	0	100	kHz
frequency		fc∟k ≥ 1 MHz	1.8 V ≤ EVDD0 ≤ 5.5 V	0	100	0	100	0	100	kHz
			1.7 V ≤ EVDD0 ≤ 5.5 V	0	100	0	100	0	100	kHz
			1.6 V ≤ EVDD0 ≤ 5.5 V	_	_	0	100	0	100	kHz
Setup time of	tsu: sta	2.7 V ≤ EVDD0 ≤ \$	5.5 V	4.7		4.7		4.7		μs
restart condition		1.8 V ≤ EVDD0 ≤ \$	5.5 V	4.7		4.7		4.7		μs
		1.7 V ≤ EVDD0 ≤ \$	5.5 V	4.7		4.7		4.7		μs
		1.6 V ≤ EVDD0 ≤ \$	5.5 V	_	_	4.7		4.7		μs
Hold time Note 1	thd: STA	2.7 V ≤ EVDD0 ≤ 5.5 V		4.0		4.0		4.0		μs
		1.8 V ≤ EVDD0 ≤ 5.5 V		4.0		4.0		4.0		μs
		1.7 V ≤ EVDD0 ≤ \$	1.7 V ≤ EVDD0 ≤ 5.5 V			4.0		4.0		μs
		1.6 V ≤ EVDD0 ≤ \$	5.5 V	_	_	4.0		4.0		μs
Hold time when	tLOW	2.7 V ≤ EVDD0 ≤ \$	5.5 V	4.7		4.7		4.7		μs
SCLA0 = "L"		1.8 V ≤ EVDD0 ≤ \$	5.5 V	4.7		4.7		4.7		μs
		1.7 V ≤ EVDD0 ≤ \$	5.5 V	4.7		4.7		4.7		μs
		1.6 V ≤ EVDD0 ≤ \$	5.5 V	_	_	4.7		4.7		μs
Hold time when	thigh	2.7 V ≤ EVDD0 ≤ \$	5.5 V	4.0		4.0		4.0		μs
SCLA0 = "H"		1.8 V ≤ EVDD0 ≤ \$	5.5 V	4.0		4.0		4.0		μs
		1.7 V ≤ EVDD0 ≤ \$	5.5 V	4.0		4.0		4.0		μs
		1.6 V ≤ EVDD0 ≤ \$	5.5 V	_	_	4.0		4.0		μs

(Notes, Caution, and Remark are listed on the next page.)

(TA = -40 to +105°C, 2.4 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

(3/5)

Items	Symbol	Symbol Conditions				MAX.	Unit
Input voltage, high	VIH1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P140 to P147	Normal input buffer	0.8 EVDD0		EV <sub>DD0</sub>	V
	VIH2	P01, P03, P04, P10, P14 to P17, P30, P43, P44, P50, P53 to P55,	TTL input buffer 4.0 V ≤ EVDD0 ≤ 5.5 V	2.2		EV <sub>DD0</sub>	V
		P80, P81, P142, P143	TTL input buffer 3.3 V ≤ EV <sub>DD0</sub> < 4.0 V	2.0		EV <sub>DD0</sub>	V
			TTL input buffer 2.4 V ≤ EVDD0 < 3.3 V	1.5		EV <sub>DD0</sub>	V
	VIH3	P20 to P27, P150 to P156	0.7 Vdd		VDD	V	
	VIH4	P60 to P63	P60 to P63			6.0	V
	VIH5	P121 to P124, P137, EXCLK, EX	CLKS, RESET	0.8 Vdd		VDD	V
Input voltage, low	VIL1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P140 to P147	Normal input buffer	0		0.2 EVDD0	V
	VIL2	P01, P03, P04, P10, P14 to P17, P30, P43, P44, P50, P53 to P55,	TTL input buffer 4.0 V ≤ EVDD0 ≤ 5.5 V	0		0.8	V
		P80, P81, P142, P143	TTL input buffer 3.3 V ≤ EVDD0 < 4.0 V	0		0.5	V
			TTL input buffer 2.4 V ≤ EVDD0 < 3.3 V	0		0.32	V
	VIL3	P20 to P27, P150 to P156		0		0.3 Vdd	V
	VIL4	P60 to P63		0		0.3 EVDD0	V
	VIL5	P121 to P124, P137, EXCLK, EX	CLKS, RESET	0		0.2 Vdd	V

Caution The maximum value of ViH of pins P00, P02 to P04, P10, P11, P13 to P15, P17, P30, P43 to P45, P50 to P55, P71, P74, P80 to P82, and P142 to P144 is EVDD0, even in the N-ch open-drain mode.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

## (2) Flash ROM: 96 to 256 KB of 30- to 100-pin products

(TA = -40 to +105°C, 2.4 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

(2/2)

Parameter	Symbol			Conditions		MIN.	TYP.	MAX.	Unit
Supply cur-	IDD2	HALT mode	HS (high-speed main)	fHOCO = 64 MHz,	V <sub>DD</sub> = 5.0 V		0.79	4.86	mA
rent Note 1	Note 2		mode Note 7	fih = 32 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.79	4.86	
				fHOCO = 32 MHz,	V <sub>DD</sub> = 5.0 V		0.49	4.17	
				fih = 32 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.49	4.17	
				fHOCO = 48 MHz,	V <sub>DD</sub> = 5.0 V		0.62	3.82	
				fih = 24 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.62	3.82	
				fHOCO = 24 MHz,	V <sub>DD</sub> = 5.0 V		0.4	3.25	
				fih = 24 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.4	3.25	
				fHOCO = 16 MHz,	V <sub>DD</sub> = 5.0 V		0.38	2.28	
				fih = 16 MHz Note 4	V <sub>DD</sub> = 3.0 V		0.38	2.28	
			HS (high-speed main)	fmx = 20 MHz Note 3,	Square wave input		0.30	2.65	mA
			mode Note 7	V <sub>DD</sub> = 5.0 V	Resonator connection		0.40	2.77	
				fmx = 20 MHz Note 3,	Square wave input		0.30	2.65	
				V <sub>DD</sub> = 3.0 V	Resonator connection		0.40	2.77	
				f <sub>MX</sub> = 10 MHz Note 3,	Square wave input		0.20	1.36	
				V <sub>DD</sub> = 5.0 V	Resonator connection		0.25	1.46	
				fmx = 10 MHz Note 3,	Square wave input		0.20	1.36	
				V <sub>DD</sub> = 3.0 V	Resonator connection		0.25	1.46	
			Subsystem clock oper-	f <sub>SUB</sub> = 32.768 kHz Note 5, T <sub>A</sub> = -40°C f <sub>SUB</sub> = 32.768 kHz Note 5, T <sub>A</sub> = +25°C	Square wave input		0.28	0.66	μΑ
			ation		Resonator connection		0.47	0.85	
					Square wave input		0.34	0.66	
					Resonator connection		0.53	0.85	
				fsuB = 32.768 kHz Note 5,	Square wave input		0.37	2.35	
				T <sub>A</sub> = +50°C	Resonator connection		0.56	2.54	
				fsuB = 32.768 kHz Note 5,	Square wave input		0.61	4.08	
				T <sub>A</sub> = +70°C	Resonator connection		0.80	4.27	
				fsuB = 32.768 kHz Note 5,	Square wave input		1.55	8.09	
				T <sub>A</sub> = +85°C	Resonator connection		1.74	8.28	
				fsuB = 32.768 kHz Note 5,	Square wave input		6.00	51.00	
				T <sub>A</sub> = +105°C	Resonator connection		6.00	51.00	
	IDD3	STOP mode	TA = -40°C				0.19	0.57	μΑ
	Note 6	Note 8	T <sub>A</sub> = +25°C				0.25	0.57	
	TA = +50°C TA = +70°C				0.33	2.26			
					0.52	3.99	1		
			T <sub>A</sub> = +85°C				1.46	8.00	1
			T <sub>A</sub> = +105°C				5.50	50.00	

(Notes and Remarks are listed on the next page.)

- Note 1. Total current flowing into VDD, EVDD0, and EVDD1, including the input leakage current flowing when the level of the input pin is fixed to VDD, EVDD0, and EVDD1, or Vss, EVss0, and EVss1. The values below the MAX. column include the peripheral operation current. However, not including the current flowing into the A/D converter, D/A converter, comparator, LVD circuit, I/O port, and on-chip pull-up/pull-down resistors and the current flowing during data flash rewrite.
- Note 2. During HALT instruction execution by flash memory.
- Note 3. When high-speed on-chip oscillator and subsystem clock are stopped.
- Note 4. When high-speed system clock and subsystem clock are stopped.
- Note 5. When high-speed on-chip oscillator and high-speed system clock are stopped. When RTCLPC = 1 and setting ultra-low current consumption (AMPHS1 = 1). The current flowing into the RTC is included. However, not including the current flowing into the 12-bit interval timer and watchdog timer.
- Note 6. Not including the current flowing into the RTC, 12-bit interval timer, and watchdog timer.
- **Note 7.** Relationship between operation voltage width, operation frequency of CPU and operation mode is as below.

HS (high-speed main) mode:  $2.7 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V} @ 1 \text{ MHz to } 32 \text{ MHz}$ 

 $2.4 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V} @1 \text{ MHz to } 16 \text{ MHz}$ 

- Note 8. Regarding the value for current to operate the subsystem clock in STOP mode, refer to that in HALT mode.
- Remark 1. fmx: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)
- Remark 2. fHOCO: High-speed on-chip oscillator clock frequency (64 MHz max.)
- Remark 3. fil: High-speed on-chip oscillator clock frequency (32 MHz max.)
- Remark 4. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
- Remark 5. Except subsystem clock operation and STOP mode, temperature condition of the TYP. value is TA = 25°C

- Note 5. Current flowing only to the watchdog timer (including the operating current of the low-speed on-chip oscillator).

  The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and IWDT when the watchdog timer is in operation.
- Note 6. Current flowing only to the A/D converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IADC when the A/D converter operates in an operation mode or the HALT mode.
- Note 7. Current flowing only to the LVD circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and ILVD when the LVD circuit is in operation.
- Note 8. Current flowing during programming of the data flash.
- Note 9. Current flowing during self-programming.
- Note 10. For shift time to the SNOOZE mode, see 23.3.3 SNOOZE mode in the RL78/G14 User's Manual.
- Note 11. Current flowing only to the D/A converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IDAC when the D/A converter operates in an operation mode or the HALT mode.
- Note 12. Current flowing only to the comparator circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2, or IDD3 and ICMP when the comparator circuit is in operation.
- Note 13. A comparator and D/A converter are provided in products with 96 KB or more code flash memory.
- Remark 1. fil: Low-speed on-chip oscillator clock frequency
- Remark 2. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
- Remark 3. fclk: CPU/peripheral hardware clock frequency
- Remark 4. Temperature condition of the TYP. value is TA = 25°C

### 3.5.2 Serial interface IICA

(TA = -40 to +105°C, 2.4 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) mode		node	Unit	
			Standar	d mode	Fast	mode	
			MIN.	MAX.	MIN.	MAX.	
SCLA0 clock frequency	fscL	Fast mode: fclk ≥ 3.5 MHz	_	_	0	400	kHz
		Standard mode: fclk ≥ 1 MHz	0	100	_	_	kHz
Setup time of restart condition	tsu: sta		4.7		0.6		μs
Hold time Note 1	thd: sta		4.0		0.6		μs
Hold time when SCLA0 = "L"	tLOW		4.7		1.3		μs
Hold time when SCLA0 = "H"	tніgн		4.0		0.6		μs
Data setup time (reception)	tsu: dat		250		100		ns
Data hold time (transmission) Note 2	thd: dat		0	3.45	0	0.9	μs
Setup time of stop condition	tsu: sto		4.0		0.6		μs
Bus-free time	tbuf		4.7		1.3		μs

**Note 1.** The first clock pulse is generated after this period when the start/restart condition is detected.

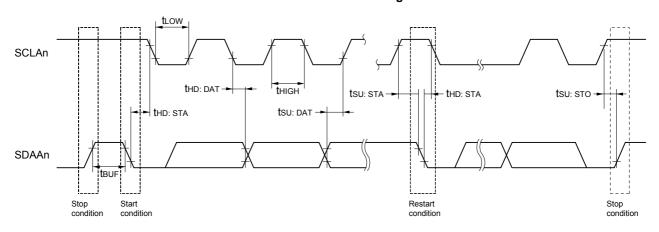
Note 2. The maximum value (MAX.) of thd: DAT is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.

Caution The values in the above table are applied even when bit 2 (PIOR02) in the peripheral I/O redirection register 0 (PIOR0) is 1. At this time, the pin characteristics (IOH1, IOL1, VOH1, VOL1) must satisfy the values in the redirect destination.

Remark The maximum value of C<sub>b</sub> (communication line capacitance) and the value of R<sub>b</sub> (communication line pull-up resistor) at that time in each mode are as follows.

Standard mode:  $C_b$  = 400 pF,  $R_b$  = 2.7 k $\Omega$ Fast mode:  $C_b$  = 320 pF,  $R_b$  = 1.1 k $\Omega$ 

### **IICA** serial transfer timing

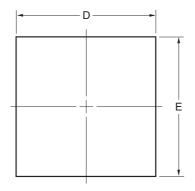


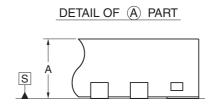
Remark n = 0, 1

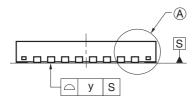
# 4.2 32-pin products

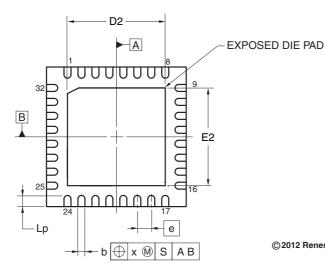
R5F104BAANA, R5F104BCANA, R5F104BDANA, R5F104BEANA, R5F104BFANA, R5F104BGANA R5F104BADNA, R5F104BCDNA, R5F104BDNA, R5F104BEDNA, R5F104BFDNA, R5F104BGDNA R5F104BAGNA, R5F104BCGNA, R5F104BDGNA, R5F104BEGNA, R5F104BGNA, R5F104BGNA

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-HWQFN32-5x5-0.50	PWQN0032KB-A	P32K8-50-3B4-4	0.06









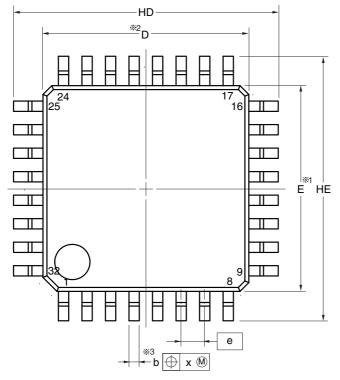
Referance	Dimension in Millimeters					
Symbol	Min	Nom	Max			
D	4.95	5.00	5.05			
Е	4.95	5.00	5.05			
Α	0.70	0.75	0.80			
b	0.18	0.25	0.30			
е		0.50	_			
Lp	0.30	0.40	0.50			
х			0.05			
у	_	_	0.05			

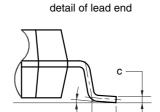
	ITEM		D2		E2			
			MIN	NOM	MAX	MIN	MOM	MAX
	EXPOSED DIE PAD VARIATIONS	Α	3.45	3.50	3.55	3.45	3.50	3.55

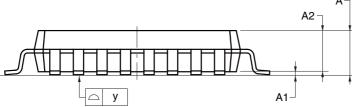
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R5F104BAAFP, R5F104BCAFP, R5F104BDAFP, R5F104BEAFP, R5F104BFAFP, R5F104BGAFP R5F104BADFP, R5F104BCDFP, R5F104BDDFP, R5F104BEDFP, R5F104BFDFP, R5F104BGDFP R5F104BAGFP, R5F104BCGFP, R5F104BDGFP, R5F104BEGFP, R5F104BFGFP, R5F104BGGFP

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LQFP32-7x7-0.80	PLQP0032GB-A	P32GA-80-GBT-1	0.2







(UNIT:mm)

	ζ -		
ITEM	DIMENSIONS		
D	7.00±0.10		
Е	7.00±0.10		
HD	9.00±0.20		
HE	9.00±0.20		
Α	1.70 MAX.		
A1	0.10±0.10		
A2	1.40		
b	$0.37{\pm}0.05$		
С	$0.145 \pm 0.055$		
L	0.50±0.20		
θ	0° to 8°		
е	0.80		
х	0.20		
v	0.10		

#### NOTE

- 1. Dimensions "%1" and "%2" do not include mold flash.
- 2.Dimension "%3" does not include trim offset.

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R5F104PKAFB, R5F104PLAFB R5F104PKGFB, R5F104PLGFB

